CMOS Digital Integrated Circuits Silicon Monolithic

# 74HC259D

#### 1. Functional Description

• 8-Bit Addressable Latch

#### 2. General

The 74HC259D is a high speed CMOS ADDRESSABLE LATCH fabricated with silicon gate  $C^2MOS$  technology. It achieve the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

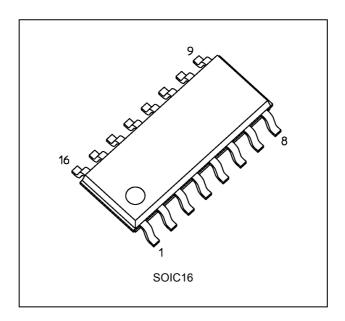
The respective bits are controlled by address inputs A, B, and C. When  $\overline{\text{CLEAR}}$  input is held high and enable input  $\overline{\text{G}}$  is held low, the data is written into the bit selected by address inputs, the other bit hold their previous conditions.

When both  $\overline{\text{CLEAR}}$  and  $\overline{\text{G}}$  held high, writing of all bits is inhibited regardless of adress inputs, and their previous condition are held. When  $\overline{\text{CLEAR}}$  is held low and  $\overline{\text{G}}$  is held high, all bits are resent to low regardless of the other inputs. When both of  $\overline{\text{CLEAR}}$  and  $\overline{\text{G}}$  held low, all bits which isn't selected by adress inputs are resent to low. All inputs are equipped with protection circuits against static discharge or transient excess voltage.

#### 3. Features

- (1) High speed:  $t_{pd}$  = 15 ns (typ.) at V<sub>CC</sub> = 5 V
- (2) Low power dissipation:  $I_{CC}$  = 4.0  $\mu$ A (max) at  $T_a$  = 25 °C
- (3) Balanced propagation delays:  $t_{PLH} \approx t_{PHL}$
- (4) Wide operating voltage range:  $V_{CC(opr)} = 2.0$  to 6.0 V

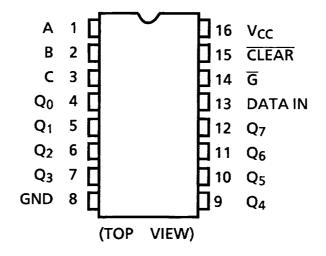
#### 4. Packaging



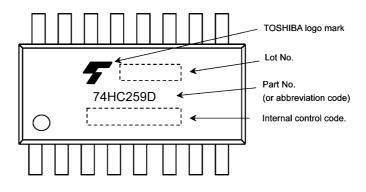
74HC259D

#### 5. Pin Assignment

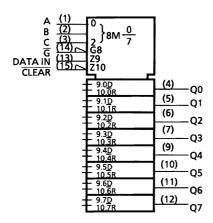
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#### 6. Marking



#### 7. IEC Logic Symbol



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#### 8. Truth Table

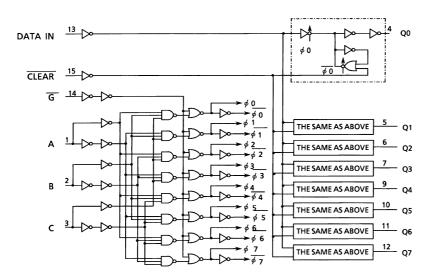
Input	s	Output of Addressed	Each Other	Function
CLEAR	IJ	Latch	Output	Function
н	L	D	QiO	Addressable Latch
н	Н	QiO	QiO	Memory
L	L	D	L	8-Line Demultriplexer
L	Н	L	L	Clear All Bits to "L"

Se	elect Inp	uts	Latab Addressed
С	В	А	Latch Addressed
L	L	L	Q0
L	L	н	Q1
L	Н	L	Q2
L	Н	н	Q3
Н	L	L	Q4
Н	L	н	Q5
Н	Н	L	Q6
Н	Н	Н	Q7

D: The level at the data input

QiO: The level before the indicared steady-state input conditions were established (i = 0, 1, ..... 7)

#### 9. System Diagram



#### 10. Absolute Maximum Ratings (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V <sub>CC</sub>		-0.5 to 7.0	V
Input voltage	V <sub>IN</sub>		-0.5 to V <sub>CC</sub> + 0.5	V
Output voltage	V <sub>OUT</sub>		-0.5 to V <sub>CC</sub> + 0.5	V
Input diode current	I <sub>IK</sub>		±20	mA
Output diode current	I <sub>ОК</sub>		±20	mA
Output current	I <sub>OUT</sub>		±25	mA
V <sub>CC</sub> /ground current	I <sub>CC</sub>		±50	mA
Power dissipation	PD	(Note 1)	500	mW
Storage temperature	T <sub>stg</sub>		-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1:  $P_D$  derates linearly with -8 mW/°C above 85 °C

#### 11. Operating Ranges (Note)

Characteristics	Symbol	Test Condition	Rating	Unit
Supply voltage	V <sub>CC</sub>	—	2.0 to 6.0	V
Input voltage	V <sub>IN</sub>	—	0 to V <sub>CC</sub>	V
Output voltage	V <sub>OUT</sub>	—	0 to V <sub>CC</sub>	V
Operating temperature	T <sub>opr</sub>	—	-40 to 125	°C
Input rise and fall times	t <sub>r</sub> ,t <sub>f</sub>	—	0 to 50	μS

Note: The operating ranges are required to ensure the normal operation of the device. Unused inputs must be tied to either  $V_{CC}$  or GND.

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#### 12. Electrical Characteristics

### 12.1. DC Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Тур.	Max	Unit
High-level input voltage	V <sub>IH</sub>	—		2.0	1.50	—	_	V
				4.5	3.15	_	_	
				6.0	4.20	—	_	
Low-level input voltage	VIL	—		2.0	—	_	0.50	V
				4.5	—	—	1.35	
				6.0	—	—	1.80	
High-level output voltage	V <sub>OH</sub>	$V_{IN} = V_{IH} \text{ or } V_{IL}$	I <sub>OH</sub> = -20 μA	2.0	1.9	2.0	_	V
				4.5	4.4	4.5	—	
				6.0	5.9	6.0	_	
			I <sub>OH</sub> = -4 mA	4.5	4.18	4.31	_	
			I <sub>OH</sub> = -5.2 mA	6.0	5.68	5.80	_	
Low-level output voltage	V <sub>OL</sub>	$V_{IN} = V_{IH} \text{ or } V_{IL}$	I <sub>OL</sub> = 20 μA	2.0	_	0.0	0.1	V
				4.5	_	0.0	0.1	
				6.0	_	0.0	0.1	
			I <sub>OL</sub> = 4 mA	4.5	—	0.17	0.26	
			I <sub>OL</sub> = 5.2 mA	6.0	_	0.18	0.26	
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		6.0	_		±0.1	μA
Quiescent supply current	I <sub>CC</sub>	$V_{IN} = V_{CC}$ or GND		6.0	_	_	4.0	μA

### 12.2. DC Characteristics (Unless otherwise specified, $T_a = -40$ to 85 °C)

Characteristics	Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Max	Unit
High-level input voltage	V <sub>IH</sub>	_		2.0	1.50	_	V
				4.5	3.15	_	1
				6.0	4.20	_	]
Low-level input voltage	V <sub>IL</sub>	—		2.0	_	0.50	V
				4.5		1.35	
				6.0	_	1.80	
High-level output voltage	V <sub>OH</sub>	$V_{IN} = V_{IH} \text{ or } V_{IL}$	I <sub>OH</sub> = -20 μA	2.0	1.9	—	<ul> <li></li> </ul>
				4.5	4.4	—	
				6.0	5.9	—	
			I <sub>OH</sub> = -4 mA	4.5	4.13	—	
			I <sub>OH</sub> = -5.2 mA	6.0	5.63	—	
Low-level output voltage	V <sub>OL</sub>	$V_{IN} = V_{IH} \text{ or } V_{IL}$	I <sub>OL</sub> = 20 μA	2.0	_	0.1	V
				4.5	_	0.1	
				6.0	_	0.1	
			I <sub>OL</sub> = 4 mA	4.5	_	0.33	
			I <sub>OL</sub> = 5.2 mA	6.0	_	0.33	
Input leakage current	I <sub>IN</sub>	$V_{IN} = V_{CC}$ or GND		6.0	_	±1.0	μA
Quiescent supply current	I <sub>CC</sub>	$V_{IN} = V_{CC}$ or GND		6.0	_	40.0	μA

#### 12.3. DC Characteristics (Unless otherwise specified, $T_a = -40$ to 125 °C)

Characteristics	Symbol	Test Condition	I	V <sub>CC</sub> (V)	Min	Max	Unit
High-level input voltage	VIH	—		2.0	1.50	—	V
				4.5	3.15	_	
				6.0	4.20	_	
Low-level input voltage	VIL	_		2.0	_	0.50	V
				4.5	_	1.35	
				6.0	_	1.30	
High-level output voltage	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -20 μA	2.0	1.9	_	V
				4.5	4.4	_	
				6.0	5.9	_	
			I <sub>OH</sub> = -4 mA	4.5	3.7	_	
			I <sub>OH</sub> = -5.2 mA	6.0	5.2	_	
Low-level output voltage	V <sub>OL</sub>	$V_{IN} = V_{IH} \text{ or } V_{IL}$	I <sub>OL</sub> = 20 μA	2.0	_	0.1	V
				4.5	_	0.1	
				6.0	_	0.1	
			I <sub>OL</sub> = 4 mA	4.5	_	0.4	
			I <sub>OL</sub> = 5.2 mA	6.0	_	0.4	V
Input leakage current	I <sub>IN</sub>	$V_{IN} = V_{CC}$ or GND		6.0	_	±1.0	μA
Quiescent supply current	I <sub>CC</sub>	$V_{IN} = V_{CC}$ or GND		6.0		160.0	μA

# 13. Timing Requirements (Unless otherwise specified, $T_a = 25$ °C, Input: tr = tf = 6 ns)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Limit	Unit
Minimum pulse width	t <sub>w(L)</sub>	_	2.0	75	ns
( <del>G</del> )			4.5	15	
			6.0	13	]
Minimum pulse width	t <sub>w(L)</sub>	—	2.0	75	ns
(CLEAR)			4.5	15	]
			6.0	13	
Minimum setup time	t <sub>S</sub>	_	2.0	50	ns
(DATA IN)			4.5	10	
			6.0	9	
Minimum setup time	t <sub>S</sub>	_	2.0	25	ns
(A, B, C)			4.5	5	
			6.0	5	
Minimum hold time	t <sub>h</sub>	_	2.0	25	ns
(DATA IN)			4.5	5	
			6.0	5	
Minimum hold time	t <sub>h</sub>	_	2.0	0	ns
(A, B, C)			4.5	0	
			6.0	0	

# 13.1. Timing Requirements (Unless otherwise specified, $T_a = -40$ to 85 °C, Input: $t_r = t_f = 6$ ns)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Limit	Unit
Minimum pulse width	t <sub>w(L)</sub>	_	2.0	95	ns
(G)			4.5	19	
			6.0	16	
Minimum pulse width	t <sub>w(L)</sub>	_	2.0	95	ns
(CLEAR)			4.5	19	
			6.0	16	
Minimum setup time	ts		2.0	60	ns
(DATA IN)			4.5	12	
			6.0	11	
Minimum setup time	ts		2.0	30	ns
(A, B, C)			4.5	6	
			6.0	5	
Minimum hold time	t <sub>h</sub>	_	2.0	30	ns
(DATA IN)			4.5	6	
			6.0	5	
Minimum hold time	t <sub>h</sub>	_	2.0	0	ns
(A, B, C)			4.5	0	]
			6.0	0	

# 13.2. Timing Requirements (Unless otherwise specified, $T_a = -40$ to 125 °C, Input: $t_r = t_f = 6$ ns)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Limit	Unit
Minimum pulse width	t <sub>w(L)</sub>	—	2.0	115	ns
( <del>G</del> )			4.5	23	]
			6.0	20	]
Minimum pulse width	t <sub>w(L)</sub>	_	2.0	115	ns
(CLEAR)			4.5	23	]
			6.0	20	
Minimum setup time	ts	_	2.0	75	ns
(DATA IN)			4.5	15	
			6.0	13	
Minimum setup time	ts	_	2.0	40	ns
(A, B, C)			4.5	8	
			6.0	7	
Minimum hold time	t <sub>h</sub>	—	2.0	40	ns
(DATA IN)			4.5	8	
			6.0	7	
Minimum hold time	t <sub>h</sub>	_	2.0	0	ns
(A, B, C)			4.5	0	
			6.0	0	

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#### 14. AC Characteristics

#### (Unless otherwise specified, $C_L = 15 \text{ pF}$ , $V_{CC} = 5 \text{ V}$ , $T_a = 25 \text{ °C}$ , Input: $t_r = t_f = 6 \text{ ns}$ )

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Output transition time	t <sub>TLH</sub> ,t <sub>THL</sub>	—	_	4	8	ns
Propagation delay time (DATA IN - Q)	t <sub>PLH</sub> ,t <sub>PHL</sub>	_	_	15	22	ns
Propagation delay time (A, B, C - Q)	t <sub>PLH</sub> ,t <sub>PHL</sub>	_	_	21	32	ns
Propagation delay time (G - Q)	t <sub>PLH</sub> ,t <sub>PHL</sub>	_	—	16	28	ns
Propagation delay time (CLEAR - Q)	t <sub>PHL</sub>	_	_	13	23	ns

#### 14.1. AC Characteristics (Unless otherwise specified, $C_L = 50pF$ , $T_a = 25$ °C, Input: $t_r = t_f = 6$ ns)

Characteristics	Symbol	Note	V <sub>CC</sub> (V)	Min	Тур.	Max	Unit
Output transition time	t <sub>TLH</sub> ,t <sub>THL</sub>		2.0	_	30	75	ns
			4.5	_	8	15	
			6.0	—	7	13	
Propagation delay time	t <sub>PLH</sub> ,t <sub>PHL</sub>		2.0	_	56	130	ns
(DATA IN - Q)			4.5	—	18	26	
			6.0	—	15	22	
Propagation delay time	t <sub>PLH</sub> ,t <sub>PHL</sub>		2.0	_	83	185	ns
(A, B, C - Q)			4.5	—	25	37	
			6.0	—	21	31	
Propagation delay time	t <sub>PLH</sub> ,t <sub>PHL</sub>		2.0	_	67	165	ns
( <del>G</del> - Q)			4.5	_	20	33	
			6.0	—	17	28	
Propagation delay time	t <sub>PHL</sub>		2.0	_	52	135	ns
(CLEAR - Q)			4.5	_	16	27	
			6.0	_	14	23	
Input capacitance	C <sub>IN</sub>		_		3	_	pF
Power dissipation capacitance	C <sub>PD</sub>	(Note 1)	_		8		pF

Note 1: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

 $I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}$ 

#### 14.2. AC Characteristics

#### (Unless otherwise specified, $C_L = 50 \text{ pF}$ , $T_a = -40 \text{ to } 85 \text{ °C}$ , Input: $t_r = t_f = 6 \text{ ns}$ )

Characteristics	Symbol	V <sub>CC</sub> (V)	Min	Max	Unit
Output transition time	t <sub>TLH</sub> ,t <sub>THL</sub>	2.0	_	95	ns
		4.5	—	19	
		6.0	—	16	
Propagation delay time (DATA IN - Q)	t <sub>PLH</sub> ,t <sub>PHL</sub>	2.0	—	165	ns
		4.5	—	33	
		6.0	_	28	
Propagation delay time (A, B, C - Q)	t <sub>PLH</sub> ,t <sub>PHL</sub>	2.0	_	230	ns
		4.5	_	46	
		6.0	_	39	
Propagation delay time (G - Q)	t <sub>PLH</sub> ,t <sub>PHL</sub>	2.0	_	205	ns
		4.5	_	41	
		6.0	_	35	
Propagation delay time (CLEAR - Q)	t <sub>PHL</sub>	2.0	_	170	ns
		4.5	—	34	
		6.0	—	29	

#### 14.3. AC Characteristics

(Unless otherwise specified,  $C_L = 50 \text{ pF}$ ,  $T_a = -40 \text{ to } 125 \text{ °C}$ , Input:  $t_r = t_f = 6 \text{ ns}$ )

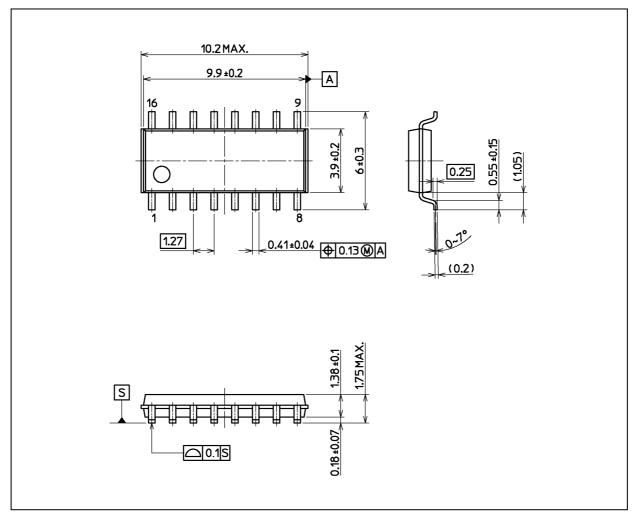
Characteristics	Symbol	V <sub>CC</sub> (V)	Min	Max	Unit
Output transition time	t <sub>TLH</sub> ,t <sub>THL</sub>	2.0	—	115	ns
		4.5	—	23	
		6.0	—	20	
Propagation delay time (DATA IN - Q)	t <sub>PLH</sub> ,t <sub>PHL</sub>	2.0	—	195	ns
		4.5	—	39	
		6.0	_	33	
Propagation delay time (A, B, C - Q)	t <sub>PLH</sub> ,t <sub>PHL</sub>	2.0	_	280	ns
		4.5	_	56	
		6.0	_	48	
Propagation delay time (G - Q)	t <sub>PLH</sub> ,t <sub>PHL</sub>	2.0	_	235	ns
		4.5	_	47	
		6.0	_	40	
Propagation delay time (CLEAR - Q)	t <sub>PHL</sub>	2.0	_	205	ns
		4.5	—	41	
		6.0		35	



#### **Package Dimensions**

74HC259D

Unit: mm



Weight: 0.15 g (typ.)

Package Name(s)
Nickname: SOIC16

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